

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination KAIDA ET AL.	
		Examiner Jennifer R. Sadula	Art Unit 1756	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,787,621	09-2004	Kim et al.	526/204
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	05-232623	09-1993	Japan	Yukio et al.	C03C 1/73
	O	08-069083	03-1996	Japan	Shinichi	C03C 1/73
	P	09-311356	12-1997	Japan	Takeshi et al.	G02F 1/19
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English translation of Yukio et al.
	V	English translation of Shinichi
	W	English translation of Takeshi et al.
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.